## Search Notes



Applic	cation/Control No.	Applicant(s)/Patent Under Reexamination
10642	647	MIURA ET AL.
Exam	iner	Art Unit
Wang	, Claire	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	236, 239, 232	1/29/2007	CW		
375	240.05, 240.07	1/29/2007	CW		
382	236, 239, 232	07/22/2007	CW		
375	240.05, 240.07	07/22/2007	CW		

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor Name Search	1/21/2007	CW		
Consulted with Wenpeng Chen (PE)	1/25/2007	CW		
Attached EAST Search	1/29/2007	CW		
Updated EAST Search attached	07/22/2007	CW		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examine		